## U.S. PATENT DOCUMENTS

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## FOREIGN PATENT DOCUMENTS

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## OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

カム	АА	IEEE Draft P802.3ah/D1.0; 2002; 599 ngs.			
TL	AB	LIM, Seyountet al.; OAM Capability Discovery; IEFE 802 3ah EFM - New Orleans, September 2002; 9 pgs.			
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